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DESCRIPTION

The H11GX series are photodarlington-type optically coupled optocouplers. These devices have a gallium arsenide infrared emitting diode coupled with a silicon darlington connected phototransistor which has an integral base-emitter resistor to optimize elevated temperature characteristics.

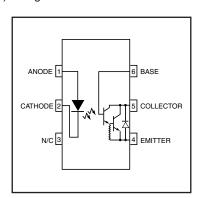
H11G1 H11G2 H11G3

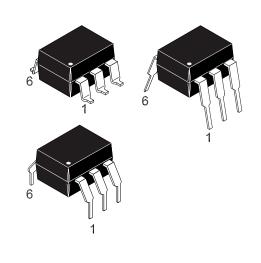
FEATURES

- High BV_{CEO}
- Minimum 100 V for H11G1
- Minimum 80 V for H11G2
- Minimum 55 V for H11G3
- High sensitivity to low input current Minimum 500 percent CTR at I_F = 1 mA
- Low leakage current at elevated temperature (maximum 100 μA at 80°C)
- Underwriters Laboratory (UL) recognized File# E90700

APPLICATIONS

- CMOS logic interface
- Telephone ring detector
- Low input TTL interface
- Power supply isolation
- Replace pulse transformer





NOTEAll dimensions are in inches (millimeters)

ABSOLUTE MAXIMUM RATINGS					
Parameter	Symbol	Value	Units		
TOTAL DEVICE	_	55 to 1450	00		
Storage Temperature	T _{STG}	-55 to +150	°C		
Operating Temperature	T _{OPR}	-55 to +100	°C		
Lead Solder Temperature	T _{SOL}	260 for 10 sec	°C		
Total Device Power Dissipation @ T _A = 25°C		260	mW		
Derate above 25°C	P_{D}	3.5	mW/°C		
Input-Output Isolation Voltage	V _{ISO}	5300	Vac(rms)		
EMITTER		00	mA		
Forward Input Current	I _F	60			
Reverse Input Voltage	V _R	6.0	V		
Forward Current - Peak (1µs pulse, 300pps)	I _F (pk)	3.0	А		
LED Power Dissipation @ T _A = 25°C	Б	100	mW		
Derate above 25°C	P_{D}	1.8	mW/°C		
DETECTOR					
Collector-Emitter Voltage					
H11G1	V _{CEO}	100	V		
H11G2		80			
H11G3		55			
Detector Power Dissipation @ T _A = 25°C	Б.	200	mW		
Derate above 25°C	P _D	2.67	mW/°C		



H11G1, H11G2, H11G3

ELECTRICAL CHARACTERISTICS (T_A = 25°C Unless otherwise specified.)

INDIVIDUAL COMPONENT CHARACTERISTICS								
Characteristic	Test Conditions	Symbol	Device	Min	Typ**	Max	Unit	
EMITTER Forward Voltage	(I _F = 10 mA)	V _F	ALL		1.3	1.50	V	
Forward Voltage Temp. Coefficient		$\frac{\Delta V_F}{\Delta T_A}$	ALL		-1.8		mV/°C	
Reverse Breakdown Voltage	(I _R = 10 μA)	BV _R	ALL	3.0	25		V	
Lunction Conneitance	$(V_F = 0 V, f = 1 MHz)$	CJ	ALL		50		pF	
Junction Capacitance	$(V_F = 1 V, f = 1 MHz)$		ALL		65		pF	
Reverse Leakage Current	$(V_{R} = 3.0 \text{ V})$	I _R	ALL		0.001	10	μΑ	
DETECTOR			H11G1	100				
Breakdown Voltage	$(I_C = 1.0 \text{ mA}, I_F = 0)$	BV _{CEO}	H11G2	80			1	
Collector to Emitter			H11G3	55				
	(I _C = 100 μA)	BV _{CBO}	H11G1	100			V	
Collector to Base			H11G2	80				
			H11G3	55				
Emitter to Base		BV _{EBO}	ALL	7	10			
	$(V_{CE} = 80 \text{ V}, I_{F} = 0)$	I _{CEO}	H11G1				nA	
Lookogo Current	$(V_{CE} = 60 \text{ V}, I_{F} = 0)$		H11G2			100		
Leakage Current	$(V_{CE} = 30 \text{ V}, I_{F} = 0)$		H11G3					
Collector to Emitter	$(V_{CE} = 80 \text{ V}, I_F = 0, T_A = 80^{\circ}\text{C})$		1	H11G1			100	
	$(V_{CE} = 60 \text{ V}, I_F = 0, T_A = 80^{\circ}\text{C})$		H11G2			100	μΑ	

TRANSFER CHARACTERISTICS							
DC Characteristic	Test Conditions	Symbol	Device	Min	Typ**	Max	Unit
EMITTER Current Transfer Ratio Collector to Emitter	$(I_F = 10 \text{ mA}, V_{CE} = 1 \text{ V})$	CTR	H11G1/2	100 (1000)			mA (%)
	$(I_F = 1 \text{ mA}, V_{CE} = 5 \text{ V})$		H11G1/2 H11G3	5 (500) 2 (200)			
Saturation Voltage	$(I_F = 16 \text{ mA}, I_C = 50 \text{ mA})$		H11G1/2		0.85	1.0	
	$(I_F = 1 \text{ mA}, I_C = 1 \text{ mA})$	V _{CE (SAT)}	H11G1/2		0.75	1.0	V
	$(I_F = 20 \text{ mA}, I_C = 50 \text{ mA})$		H11G3		0.85	1.2	

TRANSFER CHARACTERISTICS							
Characteristic	Test Conditions	Symbol	Device	Min	Typ**	Max	Unit
SWITCHING TIM	IES $(R_{l} = 100 \ \Omega, \ l_{F} = 10 \ mA)$	+	ALL		5		
Turn-on Time	(nL = 100 32, if = 10 IIIA)	t _{on}	ALL		5		μs
Turn-off Time	(V _{CE} = 5 V) Pulse Width \leq 300 μ s, f \leq 30 Hz)	t _{off}	ALL		100		

^{**} All typical values at $T_A = 25$ °C



H11G1, H11G2, H11G3

Fig. 1 Output Current vs. Input Current

Normalized to:

VCE = 5 V

IF = 1 mA

Fig. 2 Normalized Output Current vs. Temperature 100 Ic - NORMALIZED OUTPUT CURRENT Normalized to: $V_{CE} = 5 V$ $I_F = 1 \text{ mA}$ $T_A = 25^{\circ}\text{C}$ 50 mA = 1 mA $= 0.5 \, \text{mA}$ 0.01 -60 -40 20 40 80 100 120 TA - AMBIENT TEMPERATURE (°C)

Fig. 3 Output Current vs. Collector - Emitter Voltage

IF - LED INPUT CURRENT(mA)

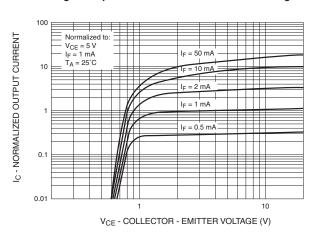


Fig. 4 Collector-Emitter Dark Current vs. Ambient Temperature

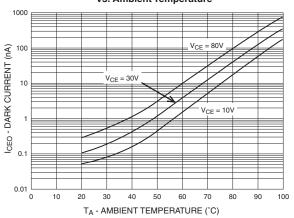
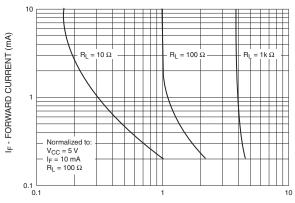


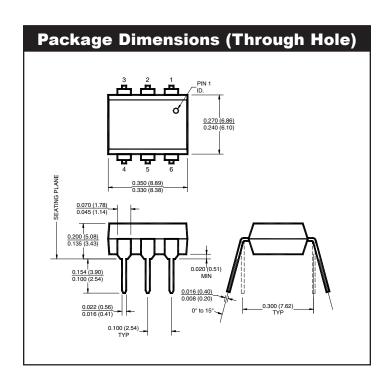
Fig. 5 Input Current vs. Total Switching Speed (Typical Values)

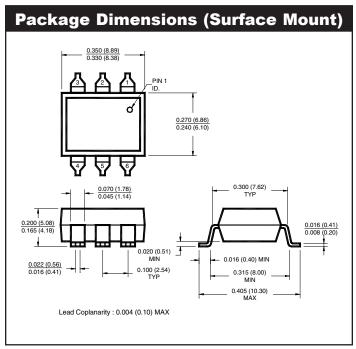


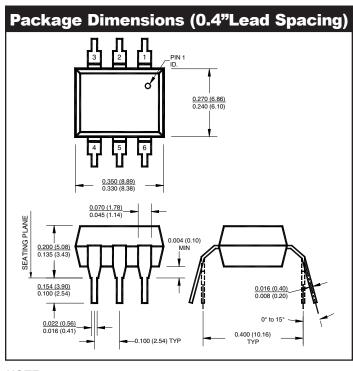
 $t_{\mbox{\scriptsize on}}$ + $t_{\mbox{\scriptsize off}}$ - TOTAL SWITCHING SPEED (NORMALIZED)

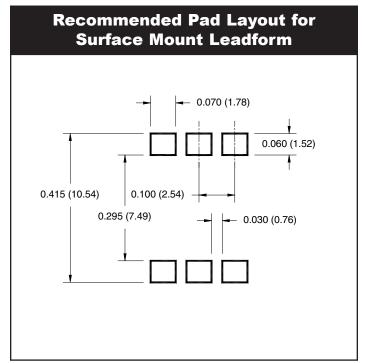


H11G1, H11G2, H11G3









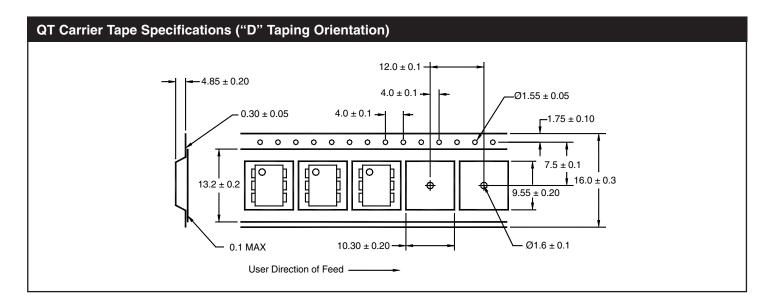
NOTEAll dimensions are in inches (millimeters)



H11G1, H11G2, H11G3

ORDERING INFORMATION

Option	Order Entry Identifier	Description		
S	.S	Surface Mount Lead Bend		
SD	.SD	Surface Mount; Tape and reel		
W	.W	0.4" Lead Spacing		
300	.300	VDE 0884		
300W	.300W	VDE 0884, 0.4" Lead Spacing		
3S	.3\$	VDE 0884, Surface Mount		
3SD	.3SD	VDE 0884, Surface Mount, Tape & Reel		



NOTE

All dimensions are in millimeters



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